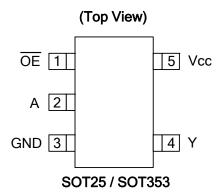


Description

The 74LVCE1G125 is a single non-inverting buffer/bus driver with a 3-state output. The output enters a high impedance state when a HIGH-level is applied to the output enable (OE) pin. The device is designed for operation with a power supply range of 1.4V to 5.5V. The inputs are tolerant to 5.5V allowing this device to be used in a mixed voltage environment. The device is fully specified for partial power down applications using $I_{\rm OFF}$. The $I_{\rm OFF}$ circuitry disables the output preventing damaging current backflow when the device is powered down.

Pin Assignments



Features

- Extended Supply Voltage Range from 1.4 to 5.5V
- Switching speed characterized for operation at 1.5V
- Offers 30% speed improvement over LVC at 1.8V.
- ± 24mA Output Drive at 3.3V
- CMOS low power consumption
- IOFF Supports Partial-Power-Down Mode Operation
- Inputs accept up to 5.5V
- ESD Protection Exceeds JESD 22
- 200-V Machine Model (A115-A)
- 2000-V Human Body Model (A114-A)
- Latch-Up Exceeds 100mA per JESD 78, Class II
- Range of Package Options
- Direct Interface with TTL Levels
- SOT25 and SOT353: Assembled with "Green" Molding Compound (No Br, Sb)
- Lead Free Finish/ RoHS Compliant (Note 1)

Applications

- Voltage Level Shifting
- Bus Driver / Repeater
- Power Down Signal Isolation
- General Purpose Logic
- Wide array of products such as.
 - PCs, networking, notebooks, netbooks, PDAs
 - · Computer peripherals, hard drives, CD/DVD ROM
 - TV, DVD, DVR, set top box
 - · Cell Phones, Personal Navigation / GPS
 - MP3 players ,Cameras, Video Recorders

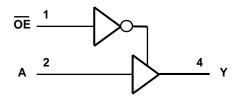
Notes: 1. EU Directive 2002/95/EC (RoHS). All applicable RoHS exemptions applied. Please visit our website at http://www.diodes.com/products/lead_free.html.



Pin Descriptions

Pin Name	Pin NO.	Description
ŌE	1	Output Enable (active low)
А	2	Data Input
GND	3	Ground
Υ	4	Data Output
Vcc	5	Supply Voltage

Logic Diagram



Function Table

Inp	Inputs					
ŌĒ	Α	Y				
L	Н	Н				
L	L	L				
Н	Х	Z				



Absolute Maximum Ratings (Note 2)

Symbol	Description	Rating	Unit
ESD HBM	Human Body Model ESD Protection	2	KV
ESD MM	Machine Model ESD Protection	200	V
V _{CC}	Supply Voltage Range	-0.5 to 6.5	V
VI	Input Voltage Range	-0.5 to 6.5	V
Vo	Voltage applied to output in high impedance or I _{OFF} state	-0.5 to 6.5	V
Vo	Voltage applied to output in high or low state	-0.3 to V _{CC} +0.5	V
I _{IK}	Input Clamp Current V _I <0	-50	mA
I _{ok}	Output Clamp Current	-50	mA
Io	Continuous output current	±50	mA
	Continuous current through Vdd or GND	±100	mA
TJ	Operating Junction Temperature	-40 to 150	°C
T _{STG}	Storage Temperature	-65 to 150	°C

Notes: 2. Stresses beyond the absolute maximum may result in immediate failure or reduced reliability. These are stress values and device operation should be within recommend values.



Recommended Operating Conditions (Note 3)

Symbol		Parameter	Min	Max	Unit	
\/	On a ratio a Valta as	Operating	1.4	5.5	V	
V _{cc}	Operating Voltage	Data retention only	1.2		V	
		V _{CC} = 1.4 V to 1.95 V	0.65 X V _{CC}			
\/	IPak la al las (Maltana	$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$	1.7		V	
V _{IH}	High-level Input Voltage	V _{CC} = 3 V to 3.6 V	2		V	
		$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V}$	0.7 X V _{CC}			
		V _{CC} = 1.4 V to 1.95 V		0.35 X V _{CC}		
\/	Low-level input voltage	$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$		0.7	V	
V_{IL}	Low-level input voltage	$V_{CC} = 3 \text{ V to } 3.6 \text{ V}$		0.8	V	
		$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V}$		0.3 X V _{CC}		
V _I	Input Voltage		0	5.5	V	
Vo	Output Voltage		0	V _{CC}	V	
	High-level output current	Vcc=1.4 V		-3		
		V _{CC} = 1.65 V		-4		
		$V_{CC} = 2.3 \text{ V}$		-8	m Λ	
I _{OH}		V 2.V		-16	mA	
		$V_{CC} = 3 V$		-24		
		V _{CC} = 4.5 V		-32		
		Vcc=1.4 V		3		
		V _{CC} = 1.65 V		4		
	Lavelaval autout avenue	V _{CC} = 2.3 V		8	mΑ	
I _{OL}	Low-level output current			16		
		$V_{CC} = 3 V$		24		
		V _{CC} = 4.5 V		32		
		V _{CC} = 1.4 to 3V		20		
Δt/ΔV	Input transition rise or fall	$V_{CC} = 3.3 \text{ V} \pm 0.3 \text{ V}$		10	ns/V	
	rate	$V_{CC} = 5 \text{ V} \pm 0.5 \text{ V}$		5		
T _A	Operating free-air temperature		-40	85	°C	

Notes: 3. Unused inputs should be held at Vcc or Ground.



Electrical Characteristics (All typical values are at Vcc = 3.3V, T_A = 25°C)

Over recommended free-air temperature range (unless otherwise noted)

Symbol	Parameter	Test Conditions	Vcc	Min	Тур.	Max	Unit
		$I_{OH} = -100 \mu A$	1.4 V to 5.5V	$V_{CC} - 0.1$			
		$I_{OH} = -3mA$	1.4 V	1.05			
		$I_{OH} = -4mA$	1.65 V	1.2			
V_{OH}	High Level Output Voltage	$I_{OH} = -8mA$	2.3V	1.9			V
	Voltage	$I_{OH} = -16mA$	-3 V	2.4			
		I _{OH} = -24mA	3 V	2.3			
		I _{OH} = -32mA	4.5 V	3.8			
		$I_{OL} = 100 \mu A$	1.4 V to 5.5V			0.1	
		$I_{OL} = 3mA$	1.4V			.4	
	V _{OL} High-level Input Voltage	I _{OL} = 4mA	1.65 V			0.45	
V_{OL}		$I_{OL} = 8mA$	2.3V			0.3	V
		I _{OL} = 16mA	-3 V			0.4	
		$I_{OL} = 24mA$	3 V			0.55	
		$I_{OL} = 32mA$	4.5			0.55	
I_{l}	Input Current	$V_1 = 5.5 \text{ V or GND}$	0 to 5.5 V			± 5	μΑ
I _{OFF}	Power Down Leakage Current	V_1 or $V_0 = 5.5V$	0			± 10	μA
I _{OZ}	Z State Leakage Current	V _O =0 to 5.5V	3.6V			10	μA
I _{cc}	Supply Current	$V_1 = 5.5V$ of GND $I_0=0$	1.4 V to 5.5V			10	μA
ΔI _{CC}	Additional Supply Current	One input at V _{CC} – 0.6 V Other inputs at V _{CC o} r GND	3 V to 5.5V			500	μA
C_{i}	Input Capacitance	$V_i = V_{CC} - \text{ or GND}$	3.3		3.5		pF
Δ	Thermal Resistance	SOT25	(Note 4)		204		°C/W
θ_{JA}	Junction-to-Ambient	SOT353	(Note 4)		371		°C/W
Α	Thermal Resistance	SOT25	(Note 4)		52		°C/W
θ_{JC}	Junction-to-Case	SOT353	(Note 4)		143		°C/W

Notes: 4. Test condition for SOT25 and SOT353: Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout.



Switching Characteristics

Over recommended free-air temperature range, CL = 15pF (see Figure 1)

Parameter	From TO	$_{\text{amotor}}$ From TO ± 0.1 V ± 0.15 V		Vcc = 2.5 V V ± 0.2V			Vcc = 3.3 V ± 0.3V		Vcc = 5 V ± 0.5V				
	(Input)	(OUTPUT)	Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	Unit
t _{pd}	Α	Υ	1.9	6.9	1.3	4.8	0.5	3.6	0.4	3	0.4	3	ns

Over recommended free-air temperature range, CL = 30 or 50pF as noted (see Figure 2)

Parameter	From	-	Vcc = 1.5 V ± 0.1V			Vcc = 1.8 V V ± 0.15V		Vcc = 2.5 V ± 0.2V		Vcc = 3.3 V ± 0.3V		Vcc = 5 V ± 0.5V	
	(Input)	(OUTPUT)	Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	Unit
t _{pd}	Α	Υ	2.8	9	1.9	6.3	0.9	4.4	0.8	3.6	0.9	3.6	ns
t _{en}	OE	Υ	3.3	10.1	2.3	7	1.2	5.2	0.8	4.3	0.9	4.5	
t _{dis}	OE	Υ	1.3	9.2	0.9	6.4	0.8	4	0.8	4.1	0.9	3.7	

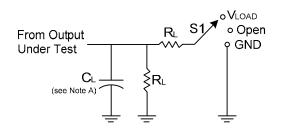
Operating Characteristics

 $T_A = 25$ °C

	Parameter		Test	Vcc = 1.5 V	Vcc = 1.8 V	Vcc = 2.5 V	Vcc = 3.3 V	Vcc = 5 V	Unit
			Conditions	TYP	TYP	TYP	TYP	TYP	
	Power dissipation	Outputs enabled	f = 10 MHz	20	20	20	21	22	nE.
С	capacitance	Outputs disabled	1 = 10 101112	2	2	2	2	4	pF

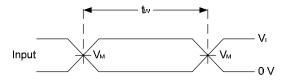


Parameter Measurement Information

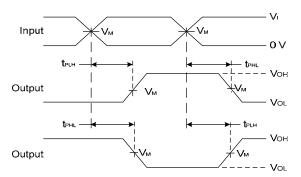


TEST	S1
t _{PLH} /t _{PHL}	Open
t _{PLZ} /t _{PZL}	Vload
t _{PHZ} /t _{PZH}	GND

Vcc	In	puts	V	C .	D.
VCC	VI	t _r /t _f	V _M C _L		R _L
1.5V±0.1V	V _{CC}	≤2ns	V _{CC} /2	15pF	1ΜΩ
1.8V±0.15V	V _{CC}	≤2ns	V _{CC} /2	15pF	1ΜΩ
2.5V±0.2V	V _{cc}	≤2ns	V _{CC} /2	15pF	1ΜΩ
3.3V±0.3V	3V	≤2.5ns	1.5V	15pF	1ΜΩ
5V±0.5V	V _{CC}	≤2.5ns	V _{CC} /2	15pF	1ΜΩ



Voltage Waveform Pulse Duration



Voltage Waveform Propagation Delay Times Inverting and Non Inverting Outputs

Output Control

Output Waveform 1
S1 at V.coab (see Note B)

Output Waveform 2
S1 at GND (see Note B) $t_{PZH} \rightarrow t_{PZH} \rightarrow t_{PHZ} \rightarrow t_{PHZ} \rightarrow t_{PHZ}$ $V_{OH} \rightarrow v_{OH} \rightarrow$

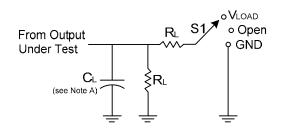
Voltage Waveform Enable and Disable Times
Low and High Level Enabling

- Notes: A. Includes test lead and test apparatus capacitance.
 - B. All pulses are supplied at pulse repetition rate ≤ 10 MHz.
 - C. Inputs are measured separately one transition per measurement.
 - D. t_{PLZ} and t_{PHZ} are the same as t_{dis.}
 - E. t_{PZL} and t_{PZH} are the same as t_{EN.}
 - F. t_{PLH} and t_{PHL} are the same as t_{PD}.

Figure 1. Load Circuit and Voltage Waveforms

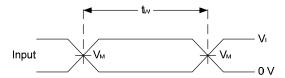


Parameter Measurement Information (Continued)

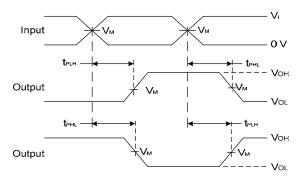


TEST	S1
t _{PLH} /t _{PHL}	Open
t_{PLZ}/t_{PZL}	Vload
t _{PHZ} /t _{PZH}	GND

Vcc	Inp	outs	V _M	CL	RL	
	VI	t _r /t _f	- 101	V _M		
1.5V±0.1V	V _{cc}	≤2ns	V _{CC} /2	30pF	1ΚΩ	
1.8V±0.15V	V _{cc}	≤2ns	V _{CC} /2	30pF	1ΚΩ	
2.5V±0.2V	V _{cc}	≤2ns	V _{CC} /2	30pF	500Ω	
3.3V±0.3V	3V	≤2.5ns	1.5V	50pF	500Ω	
5V±0.5V	V _{cc}	≤2.5ns	V _{CC} /2	50pF	500Ω	



Voltage Waveform Pulse Duration



Voltage Waveform Propagation Delay Times Inverting and Non Inverting Outputs

Output
VM

Output
Waveform 1
S1 at V_{LOAD}
(see Note B)

Output
Waveform 2
S1 at GND
(see Note B)

Output
VM

VM

VM

VM

VOL + VI

VOL + VI

VOH - VI

VOH

Voltage Waveform Enable and Disable Times Low and High Level Enabling

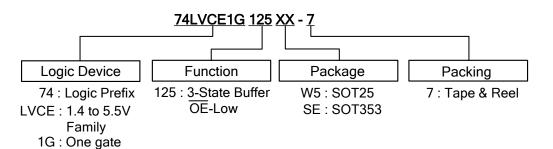
Notes: A. Includes test lead and test apparatus capacitance.

- B. All pulses are supplied at pulse repetition rate ≤ 10 MHz.
- C. Inputs are measured separately one transition per measurement.
- D. t_{PLZ} and t_{PHZ} are the same as t_{dis.}
- E. t_{PZL} and t_{PZH} are the same as t_{EN0}
- F. t_{PLH} and t_{PHL} are the same as t_{PD}.

Figure 2. Load Circuit and Voltage Waveforms



Ordering Information



	Device	Package	Packaging	7" Tape and Reel	
	Device	Code	(Note 5)	Quantity	Part Number Suffix
Pb ,	74LVCE1G125W5-7	W6	SOT25	3000/Tape & Reel	-7
Pb ,	74LVCE1G125SE-7	SE	SOT353	3000/Tape & Reel	-7

5. Pad layout as shown on Diodes Inc. suggested pad layout document AP02001, which can be found on our website at http://www.diodes.com/datasheets/ap02001.pdf.

4

3

Marking Information

(Top View)

5 XX Y WX

2

XX: Identification code

Y: Year 0~9

W: Week: A~Z: 1~26 week;

a~z: 27~52 week; z represents 52 and 53 week

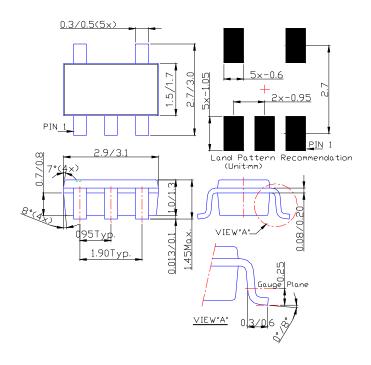
X: A~Z: Internal code

Part Number	Package	Identification Code
74LVCE1G125W5	SOT25	PY
74LVCE1G125SE	SOT353	PY

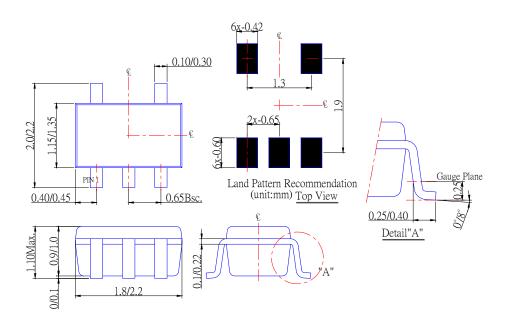


Package Outline Dimensions (All Dimensions in mm)

(1) Package Type: SOT25



(2) Package Type: SOT353





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